

Agilent E5100A Network Analyzer

Data Sheet

These specifications are the performance standards or limits against which the instrument is tested. When shipped from the factory, the E5100A meets the specifications listed in this section.

Values followed by (SPC) are supplemental performance characteristics.

Source

Frequency characteristics

| Range 10 kHz to 300 MHz |
|--|
| Accuracy (at 23 ±5 °C) ±20 ppm |
| With Option E5100A-1D5 (at 0 to 55 °C, 20 minutes after power on) . ± 1 ppm |
| Stability (at 23 ±5 °C)±5 x 10 ⁻⁶ /day (SPC) |
| With Option E5100A-1D5 (48 hours after power on) $\pm 2.5 \ge 10^{-9}/8$ hours (SPC) |
| Resolution |

Output power characteristics

| (measured at RF OUT 1, RF OUT 2 is terminated with 50 Ω termination) |
|---|
| Range (nominal) |
| With Option E5100A-001 |
| With Option E5100A-002 |
| With Option E5100A-003 |
| With Option E5100A-80148 dBm to +22 dBm |
| With Option E5100A-80254 dBm to +16 dBm |
| With Option E5100A-803 |
| With Option E5100A-600 (at RF OUT 1)52 dBm to +18 dBm |
| With Option E5100A-600 (at RF OUT 2) $\dots -65$ dBm to +5 dBm |
| |
| Resolution |
| Level accuracy (at 23 ±5 °C, 0 dBm output level, 50 MHz)±1 dB |
| Flatness (at 23 \pm 5 °C, relative to 0 dBm output level at 50 MHz) +2 dB, -4 dB |
| With Option E5100A-803+2.5 dB, -4.5 dB |
| |



| With Option E5100A-801 or E5100A-802 |
|---|
| $10 \text{ kHz} \le \text{frequency} < 50 \text{ kHz} \dots + 1.5 \text{ dB}, -6 \text{ dB} (SPC)$ |
| 50 kHz \leq frequency \leq 100 MHz $\dots +2.5$ dB, -4.5 dB |
| 100 MHz < frequency \leq 300 MHz |
| With Option E5100A-600 |
| $10 \text{ kHz} \le \text{frequency} < 50 \text{ kHz} \dots + 1.5 \text{ dB}, -7 \text{ dB} (SPC)$ |
| 50 kHz \leq frequency \leq 100 MHz $\dots +2.5$ dB, -4.5 dB |
| 100 MHz < frequency \leq 300 MHz +3 dB, -5 dB |
| Linearity (at 23 ±5 °C, relative to 0 dBm output level at 50 MHz) ±1 dB |
| With Option E5100A-801/802/803 |
| Maximum power level −70 dB ≤ power level |
| < maximum power level –60 dB ±1.5 dB |
| Maximum power level −60 dB ≤ power level |
| ≤ maximum power level±1 dB |
| Power splitter |
| (When the analyzer is equipped with Option E5100A-001 or E5100A-003, |
| delete this section.) |
| Insertion loss (When the analyzer is equipped with Option E5100A-600, |
| delete this item.) |
| Output tracking |
| Without Option E5100A-600 |
| $10 \text{ kHz} \le \text{frequency} \le 100 \text{ MHz} \dots \dots$ |
| 100 MHz < frequency \leq 300 MHz 0.2 dB (SPC) |
| With Option E5100A-600 |
| $10 \text{ kHz} \le \text{frequency} \le 100 \text{ MHz} \dots 13 \text{ dB} \pm 0.3 \text{ dB} (\text{SPC})$ |
| 100 MHz < frequency \leq 300 MHz $\dots 13$ dB ±0.5 dB (SPC) |
| Equivalent output SWR |
| Without Option E5100A-600 |
| 10 kHz \leq frequency $<$ 100 MHz $\dots \dots \dots \dots \leq$ 1.2 (SPC) |
| 100 MHz \leq frequency \leq 300 MHz $\dots \dots \dots \leq$ 1.4 (SPC) |
| With Option E5100A-600 |
| 10 kHz \leq frequency $<$ 50 kHz $\dots \dots \dots \dots \leq 2.5$ (SPC) |
| 50 kHz \leq frequency \leq 100 MHz $\dots \dots \dots \dots \leq$ 1.2 (SPC) |
| 100 MHz < frequency \leq 300 MHz $\dots \dots \dots \leq$ 1.4 (SPC) |
| Spectral purity characteristics |
| Non-harmonic spurious signals (at $< 300 \text{ MHz}$) |
| With Option E5100A-001 (at –4 dBm output level) < –45 dBc |
| With Option E5100A-002 (at –10 dBm output level) $\dots \leq -45$ dBc |
| With Option E5100A-003 (at –7 dBm output level) < –45 dBc |
| |

| With Option E5100A-600 (at 0 dBm output level) | < -45 dBc |
|---|---------------------|
| With Option E5100A-801 (at +6 dBm output level) | $<-45~\mathrm{dBc}$ |
| With Option E5100A-802 (at 0 dBm output level) | $<-45~\mathrm{dBc}$ |
| With Option E5100A-803 (at +3 dBm output level) | $<-45~\mathrm{dBc}$ |

Phase noise (at 10 kHz offset from 0 dBm fundamental) < -90 dBc/Hz

Other source information

| Reverse power protection |
|---------------------------------|
| Output connector |
| Output impedance |

Receiver

Input characteristics

Maximum input level

50 Ω input

| Frequency | RF attenuator | Maximum input level |
|------------------------------------|---------------|---------------------|
| 10 kHz \leq frequency < 200 | kHz 25 dB | 0 dBm |
| 10 kHz \leq frequency < 200 | kHz 0 dB | – 25 dBm |
| 200 kHz \leq frequency \leq 30 | 0 MHz 25 dB | +5 dBm |
| 200 kHz \leq frequency \leq 30 | 0 MHz 0 dB | – 20 dBm |

$1~\text{M}\Omega$ Input for Options E5100A-705/706/707/708

| Fr | requency ¹ | RF attenuator | Maximum input level |
|----|--|---------------|---------------------|
| 10 |) kHz \leq frequency < 200 kHz | 25 dB | 0.22 Vrms |
| 10 |) kHz \leq frequency < 200 kHz | 0 dB | 0.013 Vrms |
| 20 |)0 kHz \leq frequency \leq 300 MHz | 25 dB | 0.40 Vrms |
| 20 |)0 kHz \leq frequency \leq 300 MHz | 0 dB | 0.022 Vrms |

^{1.} Measurement frequency \leq 5 MHz

Damage level

| DC |
|---|
| AC |
| Averaging noise level (at magnitude measurement, 23 ±5 °C, RF attenuator: |
| $0 \text{ dB}, 50 \Omega \text{ input})^1$ |
| IF BW 30 kHz (at > 1 MHz)100 dBm |
| IF BW 10 kHz (at > 300 kHz) –105 dBm |
| IF BW 3 kHz (at > 100 kHz) –110 dBm |
| IF BW 1 kHz |
| 30 kHz \leq frequency $<$ 100 kHz $\dots \dots -95$ dBm |
| 100 kHz \leq frequency \leq 300 MHz $\dots \dots \dots$ |
| IF BW 300 Hz |
| 10 kHz ≤ frequency < 100 kHz100 dBm |
| 100 kHz \leq frequency \leq 300 MHz $\dots \dots \dots$ |
| IF BW 100 Hz |
| 10 kHz ≤ frequency < 100 kHz105 dBm |
| 100 kHz \leq frequency \leq 300 MHz \hdots |

Input crosstalk (When the analyzer is equipped with Option E5100A-100, delete this section.) Reference input (0 dBm input level at 10 kHz to 200 kHz and +5 dBm input level at 200 kHz to 300 MHz, RF attenuator: 25 dB, 50 Ω input) Test input (RF attenuator: 0 dB, terminated with 50 Ω termination)

| 10 kHz \leq frequency $<$ 100 kHz \ldots < -1 | 10 dB |
|--|-------|
| $100 \text{ kHz} \le \text{frequency} \le 300 \text{ MHz} \dots \le -12$ | 20 dB |

Source crosstalk

(all RF OUT and input connectors are terminated with 50 Ω terminations)

| Without Option E5100A-801/802/803 (at +5 dBm output level, |
|--|
| RF attenuator: 0 dB, 50 Ω input) |
| $10 \text{ kHz} \le \text{frequency} < 100 \text{ kHz} \dots < -110 \text{ dB} (\text{SPC})$ |
| 100 kHz \leq frequency $<$ 250 MHz $\ldots < -125$ dB (SPC) |
| $250 \text{ MHz} \le \text{frequency} \le 300 \text{ MHz} \dots < -120 \text{ dB} \text{ (SPC)}$ |
| With Option E5100A-801/802/803 (at +16 dBm output level, |
| RF attenuator: 0 dB, 50 Ω input) |
| $10 \text{ kHz} \le \text{frequency} < 100 \text{ kHz} \dots < -120 \text{ dB} (SPC)$ |
| 100 kHz \leq frequency $<$ 250 MHz $\ldots $ -135 dB (SPC) |
| 250 MHz \leq frequency \leq 300 MHz $\dots $ < -130 dB (SPC) |

^{1.} When the analyzer frequency is identical to the transmitted interference signal frequency, refer to "EMC" in "general characteristics."

Residual response

| (RF attenuator: 0 dB, except for the following points) < -80 dBm |
|--|
| 50 kHz, 100 kHz, 95.825 MHz, 95.875 MHz,159.791667 MHz, 159.825 MHz, |
| 159.841667 MHz, 159.875 MHz, 239.75 MHz, and 239.875 MHz |
| Input connectorBNC female |
| With Option E5100A-705/706/707/708 BNC female, |
| Type-N female (for A, B inputs) |
| Measurement mode |
| With Option E5100A-100A |
| With Option E5100A-200 or E5100A-600A/R, R/A, R, A |
| With Option E5100A-300 A/R, B/R, R/A, B/A, R/B, A/B, R, A, B |
| With Option E5100A-400 A/R, B/R, C/R, R/A, B/A, C/A, R/B, A/B, |
| C/B, R/C, A/C, B/C, R, A, B, C |
| (When the measurement mode is either R/A, B/A, C/A, R/B, A/B, C/B, |
| |

R/C, or A/C, the specification is SPC.)

Magnitude characteristics

Absolute characteristics

Absolute amplitude accuracy

(at 23 ±5 °C, –30 dBm input level for RF attenuator: 0 dB or –5 dBm input level for RF attenuator: 25 dB, 50 Ω input)

±1 dB

Ratio characteristics

Frequency response¹ (at 23 ±5 °C, -30 dBm input level for RF attenuator: 0 dB or -5 dBm input level for RF attenuator: 25 dB, the same RF attenuator setting for both inputs) 50 Ω input 10 kHz ≤ frequency < 100 kHz</td> 100 kHz ≤ frequency ≤ 100 MHz

| $100 \text{ km} \le \text{mequency} \le 100 \text{ mm}$ | 1.1.1.1.1.1.1.1.1.1.1.1.1.1.1.1.1.1.1. |
|--|--|
| $100 \text{ MHz} < \text{frequency} \le 300 \text{ MHz}$ | ±1 dB |
| 1 M Ω input for Option E5100A-703 | /704/707/708 |
| (using 50 Ω feedthrough) | ±3 dB |

1. Frequency response can be improved by calibration.

Dynamic accuracy

(at 23 ±5 °C, 10 Hz IF BW, –10 dBm reference input level relative to maximum input level, –20 dBm test input level relative to maximum input . level, except for ramp frequency sweep)

| Test channel input level RF attenuator | | Dynamic accuracy frequency | |
|---|-----------------------------|-------------------------------|------------------|
| 25 dB | 0 dB | Other | 10 kHz to 50 kHz |
| +5 to -5 dBm ¹ | -20 to -30 dBm ² | ±0.4 dB | ±0.4 dB (SPC) |
| –5 to –15 dBm | –30 to –40 dBm | ±0.09 dB | ±0.09 dB (SPC) |
| –15 to –45 dBm | –40 to –70 dBm | ±0.05 dB | ±0.05 dB (SPC) |
| –45 to –55 dBm | –70 to –80 dBm | ±0.06 dB | ±0.1 dB (SPC) |
| –55 to –65 dBm | 80 to90 dBm | ±0.1 dB | ±0.3 dB (SPC) |
| –65 to –75 dBm | –90 to –100 dBm | ±0.3 dB | ±0.9 dB (SPC) |
| –75 to –85 dBm | –100 to –110 dBm | ±0.9 dB | ±3 dB (SPC) |
| –85 to –95 dBm | -110 to -120 dBm | ±3 dB | N/A |

With Option E5100A-100

(at 23 \pm 5 °C, 10 Hz IF BW, –20 dB input-A level relative to maximum input level, except for ramp frequency sweep, right after measuring reference)

| Test channe RF atte | | , | c accuracy uency |
|---------------------------|-----------------------------|---------|---------------------|
| 25 dB | 0 dB | Other | 10 kHz to 50 kHz |
| +5 to -5 dBm ¹ | -20 to -30 dBm ² | ±0.4 dB | ±0.4 dB (SPC) |
| –5 to –45 dBm | –30 to –70 dBm | ±0.1 dB | ±0.1 dB (SPC) |
| –45 to –55 dBm | –70 to –80 dBm | ±0.1 dB | ±0.2 dB (SPC) |
| –55 to –65 dBm | -80 to -90 dBm | ±0.2 dB | ±0.6 dB (SPC) |
| –65 to –75 dBm | –90 to –100 dBm | ±0.6 dB | ±1.8 dB (SPC) |

Trace noise

| (at 1 kHz IF BW, frequency > 305 kHz, -5 dBm input |
|---|
| level for RF attenuator: 25 dB or –30 dBm input level |
| for RF attenuator: 0 dB) |
| Stability |
| With Option E5100A-100 |
| (at 23 ±5 °C) 0.05 dB/°C (SPC) |

^{1. 0} to –5 dBm at 10 kHz to 200 kHz

^{2. -25} to -30 dBm at 10 kHz to 200 kHz

Phase characteristics

| (When the analyzer is equipped with Option E5100A-100, delete this section.) |
|--|
| Measurement modeNormal/Expanded |
| Frequency response ¹ |
| (at 23 ±5 °C, -30 dBm input level for RF attenuator: |
| 0 dB or -5 dBm input level for RF attenuator: 25 dB, |
| the same RF attenuator setting for both inputs, 50 Ω input) |
| 10 kHz \leq frequency < 100 kHz $\pm 5^{\circ}$ |
| 100 kHz \leq frequency \leq 100 MHz $\dots +2.5^{\circ}$ |
| 100 MHz < frequency \leq 300 MHz $\pm 5^{\circ}$ |
| |

Dynamic accuracy

(at 23 ±5 °C, 10 Hz IF BW, –10 dBm reference input level relative to maximum input level, $-20~\mathrm{dBm}$ test input level relative to maximum input $% -20~\mathrm{dBm}$. level, except for ramp frequency sweep)

| Test channel input level RF attenuator | | Dynamic accuracy frequency | |
|---|-----------------------------|-------------------------------|------------------|
| 25 dB | 0 dB | Other | 10 kHz to 50 kHz |
| +5 to –5 dBm ¹ | -20 to -30 dBm ² | ±3° | ±3° (SPC) |
| –5 to –15 dBm | –30 to –40 dBm | ±0.6° | ±0.6° (SPC) |
| –15 to –45 dBm | —40 to —70 dBm | ±0.3° | ±0.3° (SPC) |
| –45 to –55 dBm | —70 to —80 dBm | ±0.3° | ±0.6° (SPC) |
| –55 to –65 dBm | –80 to –90 dBm | ±0.6° | ±1.8° (SPC) |
| –65 to –75 dBm | –90 to –100 dBm | ±1.8° | ±6° SPC) |
| –75 to –85 dBm | –100 to –110 dBm | ±6° | ±18° (SPC) |
| 85 to95 dBm | -110 to -120 dBm | ±18° | NIA |

Trace noise

| (at 1 kHz IF BW, frequency > 305 kHz, -5 dBm input level |
|--|
| for RF attenuator: 25 dB or –30 dBm input level for |
| RF attenuator: 0 dB) < 50 mdeg rms |
| Stability |

^{1.} This frequency response is only for the deviation from linear phase. Frequency response can be improved by calibration.
 0 to -5 dBm at 10 kHz to 200 kHz
 -25 to -30 dBm at 10 kHz to 200 kHz

Delay characteristics

Aperture frequency $\dots \frac{200}{N-1}$ % to 100% of span, where N is number of points

Accuracy (at 23 ±5 °C, SPC)

In general, the following formula can be used to determine the accuracy, in seconds, of a specific group delay measurement:

 $\frac{Phase \ accuracy \ [deg]}{360 \ [deg] \ x \ aperture \ [Hz]} \ (sec)$

Depending on the aperture, input level, and device length, the phase accuracy used in either incremental phase accuracy or worst case phase accuracy.

General characteristics

Operating conditions When disk drive is in operation

| Temperature |
|---|
| Humidity (at wet bulb ≤ 29 °C, without condensation) . $15\% \leq \text{RH} \leq 80\%$ |
| When disk drive is not in operation |
| * |
| Temperature $\dots 5$ to 40 °C |
| Humidity (at wet bulb \leq 29 °C, without condensation) 15% \leq RH \leq 80% |
| Altitude |
| Warm-up time |
| Non-operating conditions |
| Temperature – 20 to 60 °C |
| Humidity (at wet bulb ≤ 40 °C, without condensation) $15\% \leq RH \leq 90\%$ |
| Altitude |
| SafetyCertified by CSA-C22.2 No.1010.1-92, Based on IEC 1010-1 (1990) |
| including Amendment 1 (1992) |
| EMC¹ Complies with CISPR 11(1990)/EN 55011(1991): Group 1, Class A |
| Complies with IEC 801-2 (1991)/EN 55082-1(1992): 4 kV CD, 8 kV AD |
| Complies with IEC 801-3 (1984)/EN 55082-1(1992): 3 V/m |
| Complies with IEC 801-4 (1988)/EN 55082-1(1992):1 kV power |
| lines, 0.5 kV signal lines |
| Power requirement 90 to 132 V or 198 to 264 V, 47 to 63 Hz, 400 VA max |
| Weight (depending on option) 12 kg (SPC) |
| Cabinet dimensions |

When tested at 3 V/m according to IEC 801-3/1984, the averaging noise level will be within specifications over the full immunity test frequency range of 26 to 1000 MHz except when the analyzer frequency is identical to the transmitted interference signal test frequency.

| Measurement function |
|---|
| Number of measurement channels |
| Display format |
| Sweep parameter |
| Sweep type |
| E5100A linear (step, ramp), list |
| Measurement point per sweep |
| E5100A |
| |
| Others |
| Measurement calibration Response, response and isolation, 1-port 3-term |
| Display |
| Flexible disk drive |
| binary or ASCII format |
| Flash disk |
| Ram disk |

Supplemental characteristics

Flash disk 256 Kbytes Ram disk 256 Kbytes Programming 156 Kbytes Programming 156 Kbytes Parallel I/O port 16 bit output, 8 bit input/output, TTL level Option E5100A-005 8 bit output, 4 bit input, TTL level Option E5100A-006 16 bit output, 8 bit input/output, TTL level Option E5100A-007 16 bit output, 8 bit input, open collector, opto-isolated Printer Parallel I/F (Centronics compatible), HP PCL Keyboard mini-DIN (IBM PC compatible) External video monitor output VGA

Connectors

Probe power \ldots +15 V (300 mA max.), -12.6 V (160 mA max.), GND nominal (the maximum current values are total values of each probe connector)

EXT REF INPUT 10 MHz

| Frequency |
|---|
| REF OVEN (OPTION E5100A-1D5) |
| Frequency (at 0 to 55 °C, 20 minutes after power ON)10 MHz ±1.0 ppm |
| Amplitude |
| Nominal impedance 50Ω |
| INT REF OUTPUT |
| Frequency (at 23 ±5 °C) 10 MHz ±20 ppm |
| Amplitude |
| Nominal impedance $\dots \dots \dots$ |
| EXT TRIGGER and EXT PROG RUN/CONT |
| (Positive edge trigger) |
| V_{ih} |
| V_{i1}^{i1} |
| Sink current (Is) Is ≤ 0.4 mA (SPC) |
| Pulse width (Tp) |

Furnished accessories

| Accessories | Qty. | Agilent part number |
|--|------|--------------------------|
| Power cable | 1 | - |
| Sample program disk | 1 | E5100-180X0 ¹ |
| CD-ROM (manuals) | 1 | E5100-905XX ² |
| Option E5100A-ABA add manuals | | |
| Function Reference | 1 | E5100-900X0 ² |
| Programming Manual | 1 | E5100-900X7 ² |
| User's Guide | 1 | E5100-900X1 ² |
| Instrument BASIC Users Handbook | 1 | 04155-90150 |
| Instrument BASIC Users Handbook Supplement | 1 | E5100-900X5 ² |
| Option E5100A-0BW add Service Manual | | |
| Service Manual | 1 | E5100-901X0 ² |
| Option E5100A-1CM rack mount kit | | |
| Front handle kit | 1 | 5062-3978 |
| Option E5100A-1CP front handle kit | | |
| Rack and handle kit | 1 | 5062-3990 |
| Option E5100A-1CP rack and handle kit | | |
| Rack and handle kit | 1 | 5062-3984 |
| Option E5100A-1D5 high stability frequency | | |
| BNC adapter | 1 | 1250-1859 |
| Option E5100A-1F0 external keyboard | | |
| Keyboard | 1 | - |

Furnished with special sample program disk (E5100-180X1) as well as the original one if Option E5100A-022/023 is designated. The number indicated by "X" in the part number of the sample program disk, is allocated for numbers increased by one each time a revision is made. The latest edition comes with the product.
 The number indicated by "X" in the part number of each manual, is allocated for numbers increased by one each time a revision is made. The latest edition comes with the product.

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